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# A modified magnetic bottle electron spectrometer for the detection of multiply charged ions in coincidence with all correlated electrons: decay pathways to Xe<sup>3+</sup> above xenon-4d ionization threshold

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Single-photon multiple photoionization results from electron correlations that make this process possible beyond the independent electron approximation. To study this phenomenon experimentally, the detection in coincidence of all emitted electrons is the most direct approach. It provides the relative contribution of all possible multiple ionization processes, the energy distribution between electrons that can reveal simultaneous or sequential mechanisms, and, if possible, the angular correlations between electrons. In the present work, we present a new magnet design of our magnetic bottle electron spectrometer that allows the detection of multiply charged Xe<sup>n+</sup> ions in coincidence with *n* electrons. This new coincidence detection allows more efficient extraction of minor channels that are otherwise masked by random coincidences. The proof of principle is provided for xenon triple ionization.

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## 1 Introduction

The photoelectric effect<sup>1–4</sup> is one of the cornerstones of modern physics, which is the origin of analytical methods such as X-ray photoelectron spectroscopy (XPS)<sup>5–7</sup> in chemistry and surface science. To this end, high-resolution electron spectrometers have been developed, allowing also high-resolution Auger electron spectroscopy (AES) after inner-shell ionization. At first order approximation, the independent electron model and Koopmans' theorem<sup>8</sup> are sufficient to understand the main lines resulting from inner-shell ionization in the photoelectron spectra. However, in addition to these main lines, satellite peaks corresponding to inner-shell ionization with simultaneous excitation of a valence electron (shake-up) also appear

and are a first indication of electron correlations since the absorption of a single photon induces a two-electron process. If the second electron is not simply excited but ionized, shake-up becomes shake-off, *i.e.*, double ionization (DI). Provided the photon energy is sufficient to reach multiple ionization thresholds, electron correlations make possible multiple ionization by absorption of a single photon. Conversely, multiple ionization studies provide a direct probe of electron correlations that can be accounted for at various levels of theory beyond the independent electron model with higher and higher accuracy. When the ionization process involves a deep inner-shell, cascade Auger decay becomes the dominant decay pathway leading to multiply charged ions due to the successive creation of shallower inner-shell vacancies.<sup>9,10</sup> The first important information for multiple ionization processes are the absolute cross-sections. For valence multiple ionization, these cross-sections typically decrease by one order of magnitude from *n* to the next *n* + 1 ionization levels. They can be determined by ion spectroscopy by analyzing the different charge states (*e.g.*, Li<sup>3+</sup>, ref. 11), but this provides little, if any, information on the pathways and mechanisms leading to multiple ionization. When inner-shell ionization is involved, a similar decrease by one order of magnitude is observed between single, double and multiple Auger decay and is again a direct result of electron correlations in the intermediate core-ionized states.

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## 2 Experimental approaches

The deep understanding of the mechanisms of multiple ionization relies experimentally on the detection of all the electrons in coincidence. This has been a very active field for double ionization of the simplest systems such as He and H<sub>2</sub> in the past decades.<sup>12–15</sup> Fully differential cross sections were obtained with reaction microscopes<sup>16</sup> or related techniques and were well interpreted by sophisticated theoretical models.<sup>17–19</sup> For higher ionization levels (triple, quadruple...), complete angular correlation between all electrons becomes experimentally unattainable, although it remains possible, for instance, to determine the angular correlation between two electron out of three (for example, between two Auger electrons in double Auger decay<sup>20</sup>). Nevertheless, energy correlation (without angular correlation) between many electrons remains possible in most cases.

### 2.1 The magnetic bottle

Since 2003,<sup>21</sup> experiments using magnetic bottle time-of-flight electron spectrometers<sup>22,23</sup> have allowed the study of multiple ionization processes with good energy resolution and have shown a very high sensitivity, able to reveal weak processes such as two-site double core hole ionization (K<sup>-1</sup> K<sup>-1</sup>) which is only ~10<sup>-5</sup> fraction of the prominent K<sup>-1</sup> ionization channel (see ref. 24 and references therein). Many multiple ionization channels have been revealed by this technique. For triple ionization, different channels have been observed and identified. Below the 2p inner-shell ionization threshold for Ar<sup>25</sup> and the 1s for Ne,<sup>26</sup> and in core valence–valence triple ionization of Ne,<sup>27</sup> a complete energy correlation between 3 electrons was obtained. For Kr and Xe, triple ionization occurs with 3d and 4d inner-shell ionization and results from the double Auger decay after Kr 3d<sup>28,29</sup> or Xe 4d ionization<sup>30</sup> or from a single Auger decay following core (3d, 4d) valence (4l, 5l) double ionization.<sup>31,32</sup> These last two processes have comparable cross-sections both resulting from correlations between two or three electrons in the Kr<sup>+</sup> (3d<sup>-1</sup>) or Xe<sup>+</sup> (4d<sup>-1</sup>) intermediate state, allowing double Auger decay, or in the initial Kr or Xe neutral state, allowing core-valence double ionization followed by single Auger decay.

The strength of the magnetic bottle spectrometer lies in its very high detection efficiency. The magnetic mirror configuration, that results from the strong inhomogeneous magnetic field of a permanent magnet (or electromagnet) that decreases rapidly with  $r$  as  $(L/r)^3$  ( $L$  is a characteristic dimension of the magnet ~1 cm, typically:  $B_{\max} \sim 1$  T,  $(\partial B/\partial z) \sim 0.1$  T mm<sup>-1</sup>), collects the electrons in almost the entire  $4\pi$  solid angle for energies from 0 to ~200 eV. In a distance of a few mm–cm, the electrons produced in the strong field region become almost aligned with the  $B$ -field because  $B^{1/2}/\sin\Theta$  ( $\Theta$  is the angle between the electron velocity and the  $B$ -field line) is conserved in the adiabatic approximation<sup>22</sup> (which assumes that  $\partial B/\partial z$  is small in one cyclotron gyration of the electron). At higher energies, the collection angle progressively decreases (~30% at 1 keV) as the adiabatic approximation fails and fast electrons are no longer confined on their initial  $B$ -field line. Once the

electrons trajectories are parallelized, the homogeneous weak magnetic field (~1 mT) of a long solenoid (~2 m) guides the electrons towards a microchannel plates (MCPs) assembly (Z-stack) detector.

The electron detection efficiency of MCPs, which is mainly determined by the open area ratio (OAR), is about 60% for standard MCPs, but can be ~90% higher for tapered MCPs.<sup>33–35</sup> For the detection in coincidence of 4 electrons (2 PE, 2 Auger) in the K<sup>-2</sup> process, an overall efficiency of ~20% was obtained.<sup>36</sup> With a 2 m time-of-flight tube, the energy resolution  $\Delta E/E$  is about 1.5–2%. This resolution is generally better than that of a reaction microscope, and the absolute energy resolution can be further improved by slowing down the electrons, but at the cost of losing low-energy electrons. The major limitation of the MB-TOF is the loss of any angular information, since it is no longer possible to reconstruct the trajectories from the detector back to a zone of highly inhomogeneous  $B$ -field where the electrons are generated. However, if 3 or more electrons are emitted, this angular information and the complete angular correlation between 3 electrons are no longer experimentally achievable (even with reaction microscopes).

### 2.2 Electron multi-coincidences

In order to identify and unambiguously characterize the different multiple ionization processes, the  $n$  electrons emitted during  $n$ -ionization must be detected in coincidence with good energy resolution. Since the detection efficiency, even as high as possible, is never 100%, there is a contamination of the  $n$ -ionization signal by higher order ionization processes where one or more electrons are not detected. If the dominant process is single ionization or single Auger decay after inner-shell ionization, this remains a minor problem because this contribution from the  $n + 1$  ionization levels is about one order of magnitude lower than the signal for  $n$  ionization. However, for deep inner-shell ionization, there is a dominant cascade decay channel leading to the most likely charge state  $N+$ , which may also be contaminated by higher ionization processes  $(N + i)+$ . The dominant  $N+$  ionization channel may also strongly contaminate the lower ionization channels  $(N - i)+$ . However, this contamination can be accurately estimated and often appears in a different energy range when the energy balance is considered. A more acute problem is due to parasitic processes<sup>37</sup> that can cause “unexpected” false coincidence events for higher order ionization channels. One of these processes results from collisions of fast electrons on surfaces that can produce low energy electrons in a  $(1e \rightarrow ne)$  process. This leads to contamination of the  $n$ th-order ionization signal by a lower  $m$ th-order signal and can be significantly high. In addition, when an excited ion encounters a surface, electrons can be emitted (as in the case of Penning ionization by He<sup>+</sup>\* ions) that are time-delayed due to the drift of the ions (which prohibits time to energy conversion for these electrons) and produce a false coincidence signal at any time (resulting in a spurious signal mostly at low energy after time to energy conversion). To obtain accurate results for multiple ionization channels, the true coincidence signal should not be heavily contaminated by either random coincidences (which are only statistical) nor by false coincidences when

parasitic electrons are produced. Although an estimation of “pure” random coincidences is possible (roughly, by raising to the power  $n$  the 1D signal and scaling it), it can be tedious.<sup>38–40</sup> Subtracting these random coincidences from an  $n$ -dimension data set ( $n$ -dimension matrix with sparse events) is not straightforward and relies on an algorithm to handle (multidimensional) “images”. Often, these random coincidences appear in regions of  $n$ -dimensional space that do not overlap with the  $n$ -ionization signal due to the energy difference between the different  $n$ -ionization levels. In this case, there is no need to subtract the signal of the random coincidence. However, it becomes more difficult when a minor ionization channel produces electrons that overlap in a  $n$ -dimension energy region with a prominent process (the minor channel must be, at least, higher than the statistical fluctuations of the dominant channel). The “undesirable” false coincidences (due to secondary electron processes) may be more problematic, since they may depend nonlinearly on the signal due to threshold or saturation effects. Our goal here is not to explicitly develop a method for removing this background, since many different situations can arise, but to show that we can essentially get rid of it by detecting the specific charged ion in coincidence with the associated electrons.

### 2.3 Electrons–ion coincidences

A very stringent method to filter out coincident events for  $n$ -ionization is to detect  $n$ -electrons in coincidence with the associated  $X^{n+}$  ion. This drastically reduces the contribution of false coincidences from lower ionization levels. If we assume that the main contribution to the random coincidences at level  $n + 1$  comes from ionization level  $n$  with one random electron or from level  $n - 1$  plus two random electrons, we can eliminate such contributions by detecting the  $n$  charged ion in coincidence with  $n$  electrons. This also works if only  $n$  electrons among  $(n + 1)$  are detected with an  $X^{(n+1)+}$  ion. By selecting  $n$  electron coincidence events and detecting an  $X^{n+}$  ion in coincidence, we are able to detect the true  $n$  ionization events and also accurately estimate the random coincidences where a different ion charge state is detected. This method has shown its efficiency in the past<sup>41,42</sup> but there were some limitations that we have tentatively reduced in the present work to meet our specific requirements. In this paper, we describe the prototypical simple experimental setup that was built and validated. We show how this setup was used to reveal minor processes in the triple ionization of xenon. Below, we summarize some of the methods that have been used to detect electrons and ions in coincidence with a magnetic bottle spectrometer and compare their respective advantages and possible weakness. Only magnetic bottle experiments are discussed here and not “reaction microscopes” in which the detection of electrons and ions is the “normal” mode of operation. In the experiments of ref. 41 and 42, the magnetic bottle spectrometer uses a simple conical permanent magnet. To detect ions in coincidence with electrons, their option was to detect ions on the same detector as electrons. To do this, a high pulsed potential  $V \sim 4$  kV is applied to the magnet (after some delay after the ionizing light pulse or, eventually, after the detection of the

faster electron) to accelerate the ions to give them enough energy to be detected by the MCPs, which are polarized for electron detection. The time of flight of ions (a few tens of  $\mu$ s) is much longer than that of the electrons. This method is efficient and does not result in a loss in energy resolution for the electrons. However, it is not the best option for ion resolution (a much shorter ion TOF tube with Wiley McLaren geometry provides better  $q/M$  resolution), nor for detection efficiency for fragmenting molecules,<sup>42</sup> since ions with too high initial transverse momentum are lost. Another possible drawback is the power dissipation for the pulsed field, which varies with  $fV^2$  ( $f$  is the pulse frequency). Without a high-power, high-voltage supply, it may be difficult to pulse the extraction field at more than a few kHz. In single-bunch operation of synchrotron sources, the light pulse repetition rate is typically 1 MHz, and with the light chopper we use, it is 80 kHz.<sup>43</sup> Extraction of ions with a pulsed field at this frequency is easier with a lower voltage ( $\sim 100$  V) and is also better to limit inductive signals on the detector during the steep ( $\sim 10$  ns) rising and falling edges of the HV pulse (although this parasitic signal can be vetoed). A second possibility is to extract the ion perpendicular to the MB axis through a pulsed electric field (the ions trajectories being little disturbed by the  $B$  field), with the detector located upstream of the inlet of the target gas.<sup>44</sup> Although the geometry of the electrodes used to extract the ions might appear to be a perturbation for the electrons, this is not a major problem. However, for us, this was not an option because, for metallic vapors which we want to investigate further, a cold trap is positioned in front of the oven and it is not possible to insert the ion detector there.

Another solution is to use a ring magnet and to extract the ions in the direction opposite to the electrons. This solution was first developed by Eland *et al.*<sup>45</sup> and demonstrated its efficiency for ion detection at high repetition rates. The main drawback is that the magnetic field and gradient produced by such a magnet are much lower ( $B \sim 0.1$  T) than for a plain magnet, and the relative energy resolution for electrons is therefore strongly reduced to about 5%. In the work of ref. 46, a different magnetic field configuration was optimized that produces a strong  $B$  field and a steep gradient with a 5 mm diameter hole in the magnet to extract the ions. This system allows very good detection for the ions and high resolution for the electrons (even with a short MB-TOF). Unfortunately, the chosen geometry only allows the installation of a gas inlet needle and prohibits the close approach of an oven for metallic vapors<sup>47–49</sup> with a water-cooled shield. For NdBFe permanent magnets, the temperature of the magnet must remain below 80 °C, while the oven can be heated up to 800 °C ( $\sim 535$  °C for Li  $P = 10^{-2}$  torr<sup>50</sup>). With SmCo magnets, a temperature of 350 °C could be sustainable without cooled shielding. However, the dimensions of the oven are too large (see Fig. 8 in ref. 50) and prohibit approaching the magnet tip, resulting in a rapid loss of density of the metal vapor target.

Our solution to circumvent most of these difficulties was to design a first simplest magnet configuration with a drilled soft iron pole magnetized by 12 ( $4 \times 3$ ) cubic permanent magnets.



Fig. 1 The magnetic field configuration calculated by RADIA software.<sup>51</sup>

Using the RADIA package (ESRF),<sup>51</sup> we found that the optimal geometry is to mount the magnets in a cross shape with a conical soft iron pole (Fig. 1). The magnets magnetization vector lie in the  $XY$  plane and point toward the  $Z$ -axis, the  $B$  field is channeled through the drilled conical soft iron pole in the  $Z$  direction. Using cheap commercial (NdFeB) 12 mm cubic magnets (0.5 T at the contact), a field of 0.9 T is measured on the  $Z$ -axis at the tip of the soft iron pole piece (as calculated by RADIA simulations). The shape of the permanent magnets and the soft iron pole could certainly be further optimized (although this is not trivial) to increase the field strength<sup>52</sup> while maintaining access to the oven and cold trap, but we have chosen the simplest prototype based on readily available, inexpensive permanent magnets that meets all of our requirements. This cross geometry with the conical pole allows the oven exit to be close enough to the magnet axis so that the density in the metal vapor target is sufficient. The hole in the soft iron pole had a diameter of 2 mm.

A second version of the cross-shaped magnet assembly, using four  $20 \times 20 \times 30$  mm magnets (see Fig. 1), with a 4 mm hole in the soft iron pole was built and successfully tested. The magnetic field in the  $Z$ -axis is similar in both cases, but the 4 mm hole allows a better detection of ions. A plate with a hole covered by a Mo grid (85% transparency) is placed directly in front of the conical soft iron pole (see Fig. 2). Ion extraction is performed by applying a pulsed +200 V potential to a grid located 1 cm from the magnet parallel to the plate. The distance between the magnet tip and the photon beam is 3 mm, so the ions are accelerated to  $\sim 60$  V as they enter the drilled

pole piece. The magnetic field at this distance is about 0.3 T and the  $B$  gradient remains high enough to provide good resolution for the electrons ( $\sim 2\%$ ). At this energy, the ions fly a distance of 15 mm inside the pole piece and are further accelerated to 1 kV by a few electrodes polarized with a resistive divider. Although second-order focusing conditions<sup>53</sup> are not satisfied here, we can distinguish all possible charge states of all xenon isotopes. A 12 cm long TOF tube for ions<sup>54</sup> was used with a flight at 1 kV before accelerating the ions at  $\sim 2$  kV on the front of the MCP detector to achieve a good detection efficiency (the MCP signal is extracted on the ground by capacitive decoupling for sake of simplicity). This acceleration voltage is probably not sufficient to ensure efficient detection of the low Xe charge states<sup>44</sup> and might explain some loss of ions in coincidence with electrons.

## 2.4 Experimental procedure

Using the asynchronous chopper,<sup>43</sup> the selected light pulse passing through is detected at a frequency of 80 kHz by a ceramic channeltron (Dr Sjets KBL1010  $10 \times 10$  mm<sup>2</sup>) inserted into the photon beam 20 cm after the interaction region. This signal triggers the pulsed field to extract the ions. The pulser is based on a BEHLKE switch (HTS 61-03 GSM), which is triggered by a TTL signal. This switch can in principle commute voltages up to 6 kV, but 100–200 V was sufficient for us to extract the ions.

It is worth noting that the setup can also be operated in continuous mode (without pulsed extraction): a constant potential of 3 V is applied to the grid and accelerates electrons and ions in opposite directions and allow to perform electron(s)/ion(s) coincidences. This mode results in a broadening of the electron resolution by about 100 mV when the photon beam size is 300  $\mu\text{m}$ . For pulsed mode, the typical time delay of the electronics is 300 ns and, during this time, the electrons generated by the photon pulse have already traveled several cm within the MB TOF while the ions remain in the interaction region. To avoid any disturbance of the electrons by the electric field during the pulse, a highly transparent gold mesh (95%) is placed 4 cm away from the interaction region. Regardless of whether the pulser was in operation or not, no difference was observed in the TOF spectrum of the electrons. This ensures that the shielding of the ion extraction voltage pulse by this grid is sufficient for the electrons. The 200 V pulse allows the switch to operate at a frequency of 80 kHz, and the HV power supply doesn't fail. We did not attempt to wait for the detection of a first electron to apply the extraction pulse<sup>41</sup> since the electrons time-of-flight time of 1 to 5  $\mu\text{s}$  could have been too long for the ions to remain in the interaction region. The rising edge of the voltage pulse is about 10 ns and induces transient signals by capacitive (or inductive) coupling to the different detectors. However, it was sufficient to set the thresholds of the constant fraction discriminators (CFD) for the electron, ion and photon detectors, high enough to suppress such parasitic signals, while the actual signal count rate remained almost unchanged (no veto of the signal during the pulse rise or fall was required). Fig. 1 shows the magnetic field configuration modeled with RADIA software.<sup>51</sup> The effect of the magnetic field on the ions is not really



Fig. 2 Schematic of the new magnetic bottle design and ion time-of-flight setup. (left) a photo of the cross-shaped magnet assembly with a hole diameter of 4 mm.

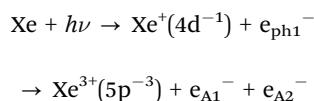
significant because their velocity is low and their time of flight for  $q/m$  analysis is based only on the electric potentials, as confirmed by the simulation of the SIMION ion trajectories.

### 3 Experimental results

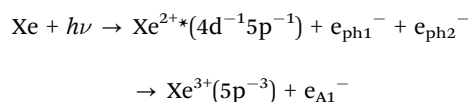
The upgraded HERMES experiment was installed at the SEXTANTS beamline of the synchrotron radiation facility SOLEIL. Our new setup of multi-electron-ion coincidence was used to study multi-ionization processes of xenon atoms, as a proof of principle.

A photon energy of 136 eV was used, allowing to open  $4d^{-1}$  single and  $4d^{-1}5l^{-1}$  ( $l = p, s$ ) double ionization (shake-off) thresholds. In particular, we focused on the triple ionization channel of Xe. In our previous work, we investigated the two “main pathways” of  $Xe^{3+}$  production.

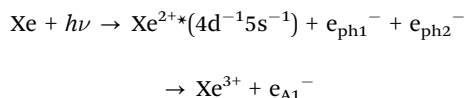
The double Auger decay after  $4d$  inner-shell ionization:<sup>30</sup>



The single Auger decay after  $4d^{-1}5p^{-1}$  double ionization:<sup>48</sup>



In this work we are more interested by a third ‘minor’ channel that could not be measured before:



We measured  $Xe^{q+}$  ions in coincidence with electrons. Fig. 3 shows the electron spectra obtained from all electrons (without filtering by ion coincidence) and in coincidence with one of the  $Xe^{q+}$  ions ( $q \leq 4$ ). The dominant channel is double ionization due to Auger decay after  $4d$  ionization. However, triple ionization is also important, while singly (due to valence ionization) and quadruply charged ions make a minor contribution (the

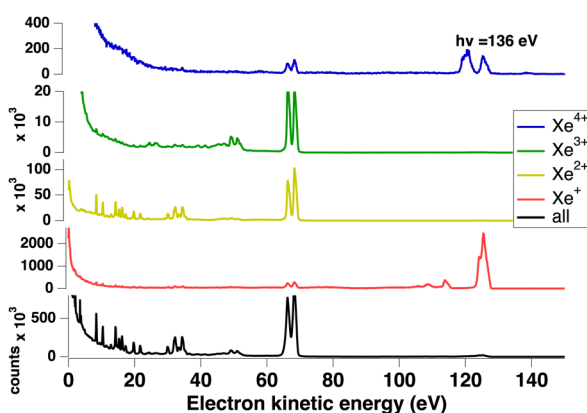


Fig. 3 Electrons spectra obtained without and with filtering by coincidence with  $Xe^{q+}$  ions ( $q \leq 4$ ).

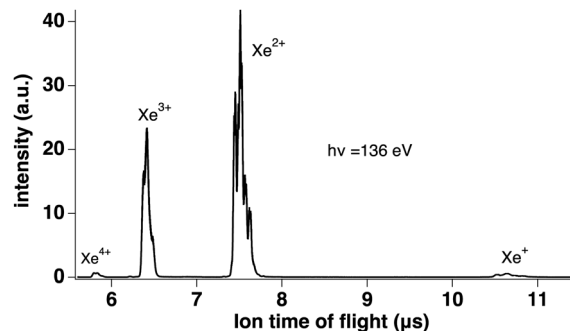


Fig. 4 Ion time-of-flight showing the production of  $Xe^{q+}$  ions ( $q \leq 4$ ).

$Xe^{4+}$  threshold is about 105 eV<sup>55</sup> and a possible pathway could be shake-off to highly excited doubly ionized  $4d^{-1}5l^{-2}nl$  states followed by double Auger decay. Ion time-of-flight Fig. 4 shows the production of  $Xe^{q+}$  ions ( $q \leq 4$ ) ions. Although the ion time-of-flight is not fully optimized for mass resolution,<sup>53</sup> the different xenon isotopes ( $M = 124-136$ ) are almost resolved. However, our goal is only to separate the different charge states.

In Fig. 5 we plot the coincidences between two electrons out of three (with all possible permutations) when exactly three electrons are detected and when a triply charged  $Xe^{3+}$  ion is detected or not in coincidence with those 3 electrons. The fraction of electrons triplets in coincidence with an  $Xe^{3+}$  ion is only  $\sim 10\%$  of the total number of three-electron events. This ratio results in part from the efficiency of the MCPs for ion detection, but certainly also from the different source volume seen for electrons and ions. The interaction volume seen by the electron MCP detector can be derived from the magnification of the magnetic bottle  $\sqrt{\frac{B_0}{B_f}} \sim 14-20$  (the field in the interaction region is between 0.2 and 0.4 T and 1 mT in the solenoid). It is therefore  $\sim 2-3$  mm (with 40 mm MCP) along the photon beam crossing the effusing gas target and larger than the 2 mm hole for ion extraction. With the 4 mm hole magnet, the detection of ions was increased and the electron/ion coincidence is higher.

In Fig. 5, without ion filtering, we see vertical and horizontal stripes resulting from random coincidences with an Auger electron, which is the dominant process. We also see a large increase in random coincidences in the low energy corner. When the 3-electron signal is filtered with the triply charged ion, these false coincidences disappear and the double Auger decay of the  $4d$  hole<sup>30</sup> appears clearly in the low energy corner. Two vertical stripes around  $E_1 = 25$  eV remain visible, corresponding to the prominent Auger lines of the  $4d^{-1}5p^{-1} Xe^{2+}$  decay (they are in coincidence with one of the two photoelectrons sharing  $\sim 45$  eV).

The two  $4d_{3/2,5/2}$  photoelectron lines at respectively  $\sim 66$  and  $68$  eV are associated in this spectra to the double Auger decay that was studied in details at a photon energy of  $\sim 110$  eV.<sup>30</sup> The double Auger spectra is exactly equivalent and shows that the electron resolution has not been altered with the hollow magnet allowing ion detection. The double Auger decay gives two Auger electrons sharing less than 5.4 eV kinetic energy. Around  $\sim 49$  and  $51$  eV two lines appear clearly that correspond

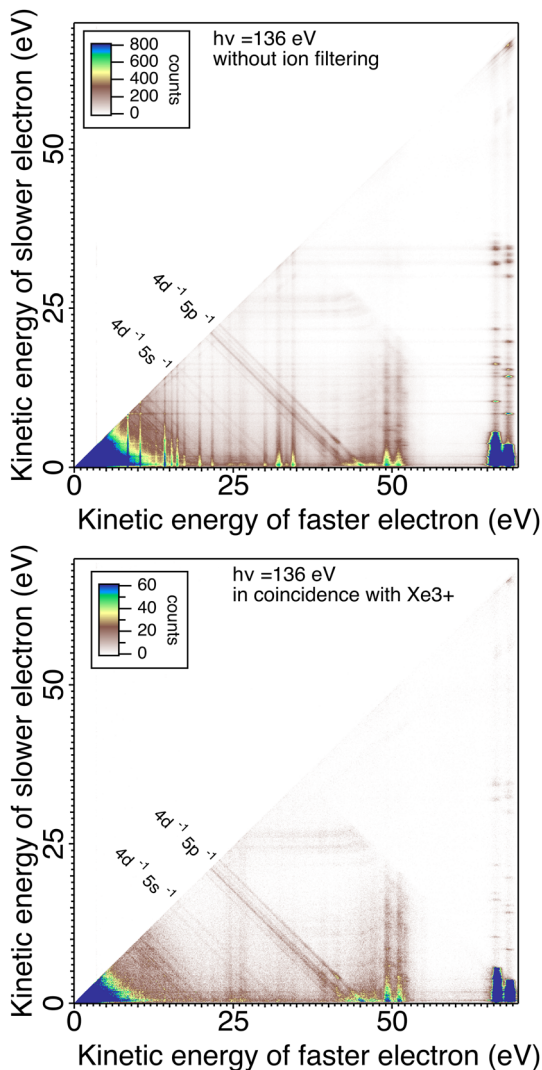


Fig. 5 Coincidence map shows the energy of the slow electron as a function of the kinetic energy of the fast following core valence double photoionization of Xe atoms at 136 eV photon energy. Top: Coincidence map for events where three electrons were detected in coincidence (without ion filtering). Bottom: Coincidence map for events where three electrons were detected in coincidence with  $\text{Xe}^{3+}$ .

to 4d shake-up states.<sup>56</sup> Although there are many possible configurations for shake-up states in this region, our limited energy resolution of about 1 eV for 50 eV electrons seems to average the states and shows two main lines corresponding to  $4d^{-1}5p^{-1}6p$  with the characteristic  $4d_{3/2,5/2}$  fine-structure splitting of 2 eV. Two other weaker lines at  $\sim 45$  and  $47$  eV could also be assigned to  $4d^{-1}5p^{-1}7p$  satellites. Just below this energy the shake-off process  $4d^{-1}5p^{-1}$  appears as diagonal lines.<sup>48</sup>

We will briefly analyze the double Auger decay associated to the main shake-up lines  $4d^{-1}5p^{-1}6p$ . These photoelectrons are coincident with two Auger electron sharing less than  $\sim 20$  eV and the coincidence between these two Auger electrons appear in the low energy corner as diagonal line corresponding to  $E_1 + E_2 < 22$  eV that are also more clearly seen in coincidence with

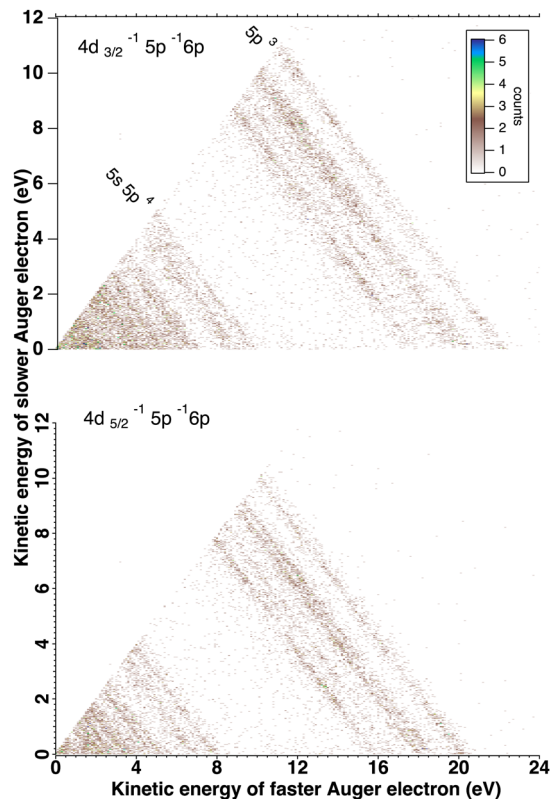


Fig. 6 Decay of xenon  $4d5p^{-1}6p$  shake states by emission of two Auger electrons. The three electrons are detected in coincidence with  $\text{Xe}^{3+}$  ion. The 2D plot of the Auger double electrons are filtered according the satellites photoelectron lines  $\sim 49$  eV (top) and  $\sim 51$  eV (bottom).

$\text{Xe}^{3+}$  ions. By selecting in the 3 electron/ $\text{Xe}^{3+}$  coincidence event, the events where an electron is a photoelectron due to  $4d_{3/2,5/2}^{-1}5p^{-1}6p$  satellite (K.E.  $\sim 49$  and  $51$  eV), we obtain the two 2D maps of Fig. 6 showing the coincidence between the two Auger electrons toward the final  $\text{Xe}^{3+}$  states. The double Auger decay from satellite states populates not only  $5p^3$  state but also  $5s5p^2$  states. Although, the energy resolution is not as good as for very low energy electrons, we can see that the cascade Auger decay is dominant. The identification of the intermediate states in the cascade is more than challenging and will not be done here. If we focus now our attention in the region  $20 < E_1 + E_2 < 50$  eV, we exclude most of the diagonal lines corresponding to double Auger decay (although double Auger decay from  $4d^{-1}5s^{-1}nl$  satellites could also be present). The dominant diagonal line at  $E_1 + E_2 \sim 45$  eV corresponds to  $4d$   $5p$  double ionization (shake-off) previously studied,<sup>48</sup> the weaker two line at  $E_1 + E_2 \sim 30$  eV are due to  $4d$   $5s$  double ionization. To better show the binding energies of those double ionized states, we plot in Fig. 8  $h\nu - (E_1 + E_2)$  against the energy  $E_3$  of the third (Auger) electron. To facilitate the identification of the process, we compiled in Fig. 7 the relevant energy level data for Xe from literature.<sup>57</sup> The horizontal bands between 90 and 95 eV can be attributed to the  $\text{Xe}^{2+} 4d^{-1}5p^{-1}$  states and their specific Auger decay is observed.<sup>48</sup> The final  $\text{Xe}^{3+}$  states appear as diagonal lines. In these lines, direct triple ionization partially

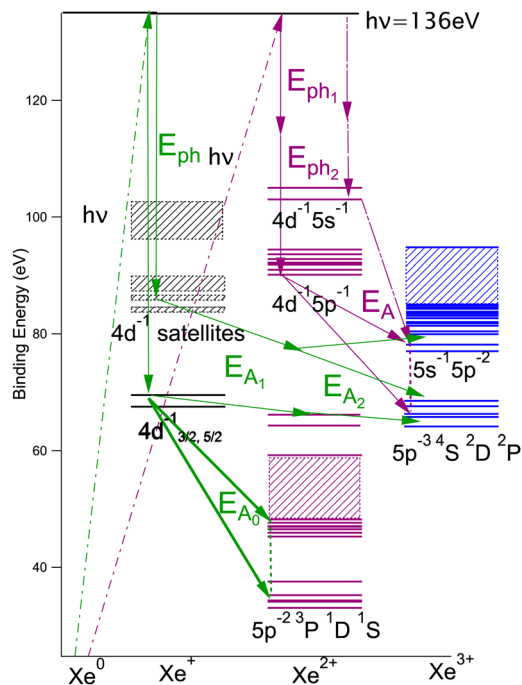


Fig. 7 Level diagram of the energy levels relevant for the interpretation of Fig. 8.

contributes in addition to the misgrouped electron pairs created by our sorting method. What can be seen now are two stripes at 104–106 eV binding energy. These two lines correspond to  $4d^{-1}5s^{-1}2D_{5/2,3/2}$  double ionization, with the  $4d_{5/2,3/2}$  2 eV spin-orbit splitting, and are now clearly observed thanks to ion filtering, whereas in our previous work they were not observed<sup>48</sup> because they were obscured by random coincidences. This clearly demonstrates the efficiency of our new ion/electron coincidence technique for studying such low cross-section events, which would otherwise not be possible.

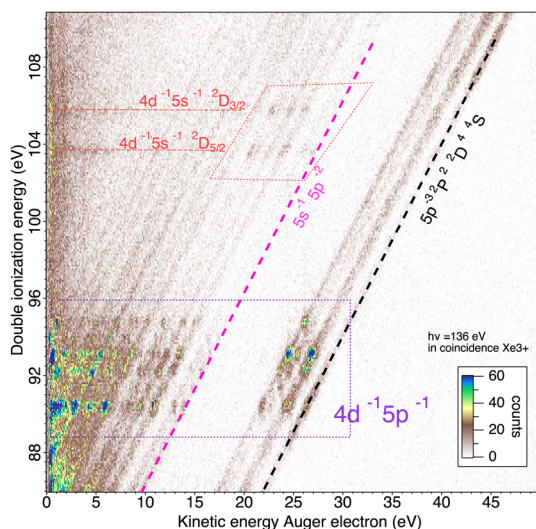


Fig. 8 2D map of core valence double photoionization of Xe atoms at 136 eV photon energy presenting the energy of the double ionized states  $h\nu - (E_1 + E_2)$  against the energy  $E_3$  of the third (Auger) electron.

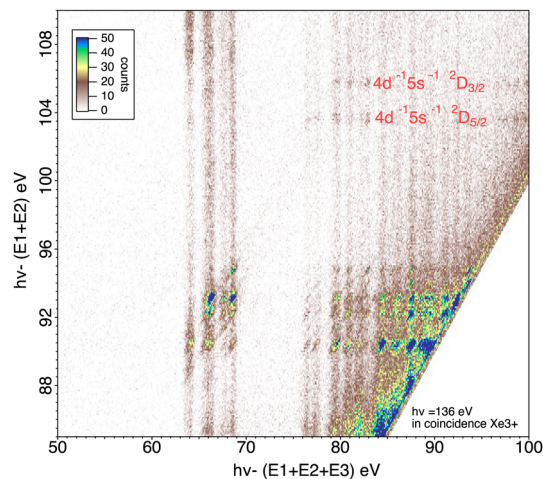


Fig. 9 2D map of core valence double photoionization of Xe atoms at 136 eV photon energy presenting the energy of the double ionized states  $h\nu - (E_1 + E_2)$  against the energy of the final  $Xe^{3+}$  states  $h\nu - (E_1 + E_2 + E_3)$ .

It is also possible to obtain the specific Auger decay of these two states  $4d^{-1}5s^{-1}2D_{5/2,3/2}$ . Another presentation of the data (Fig. 9) can be given by plotting the energy of the intermediate states given by  $h\nu - (E_1 + E_2)$  against the energy of the final  $Xe^{3+}$  states given by  $h\nu - (E_1 + E_2 + E_3)$ . In this figure the final states appear as vertical lines and the continuous intensity along a line is not only due to direct triple ionization with energy sharing between 3 electrons but also to the two summation ( $E_{PE1} + E_A$ ) and ( $E_{PE2} + E_A$ ) when the energy of the intermediate state is given by  $h\nu - (E_{PE1} + E_{PE2})$ . By subtracting a background obtained in the region where no intermediate states (horizontal lines) are visible, it is possible to obtain the Auger spectra or (equivalently) the energy of the final states by a projection of an horizontal stripe on the  $X$ -axis (Fig. 10). We observe that the decay of the  $4d^{-1}5s^{-1}$  states populates mainly the  $Xe^{3+} 5s 5p^4$  states, the 5s hole remaining spectator. The possible decay toward  $Xe^{3+} 5p^3$  final states is much more difficult to interpret. That would need a process involving three 5p electrons with simultaneous filling of 4d and 5s vacancies by two 5p electrons, the third 5p electron taking the energy being the Auger electron. That should be however a weak Auger process (unless a mixing of  $5s5p^6$  and  $5s^2 5p^5$  states due to configuration interaction allows such Auger decay by a two-electron process). The peak going to the  $Xe^{3+} 5p^3$  state could also be an artefact coming from the  $4d^{-1}5p^{-1}$  for which a combination the sum of two energies ( $E_{PE} + E_A$ ) coincides with ( $E_{PE1} + E_{PE2}$ ) for  $4d^{-1}5s^{-1}$ . There is apparently no way to exclude this process since it will be possible at any photon energy. Nor we can completely rule out the contribution of the double Auger from  $4d^{-1}5s^{-1} nl$  states that could populate the  $Xe^{3+} 5p^3$  states though cascade Auger decay with successive filling of the 4d and 5s vacancies. This process could be distinguished from double ionization followed by single Auger decay by varying the photon energy. The photon energy difference can be taken by one or two photoelectrons while the Auger energies remain constant. Unfortunately, these weak processes need high statistics to be extracted, meaning

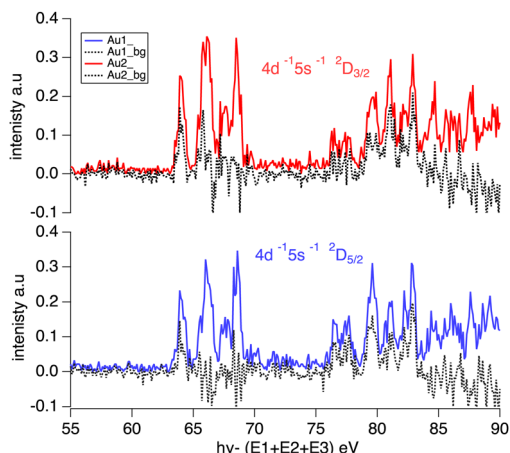


Fig. 10 The energy of the final  $\text{Xe}^{3+}$  states obtained by projecting the horizontal stripes corresponding to  $4d^{-1}5s^{-1}2D_{5/2,3/2}$  states shown in Fig. 9 onto the X axis. The black dotted lines are the same projections after suppression of the estimated background obtained in the region where there are no intermediate states (horizontal lines).

long acquisition time, that was not possible for different photon energies. If we go above  $\sim 145$  eV photon energy the 4p ionization channel opens and new Auger processes occur<sup>58</sup> that will make the interpretation of the multi-electron coincidence even more difficult, and will lead to higher charge states.

The present results conclude the previously published results obtained at 120 eV photon energy<sup>48</sup> showing clearly the double Auger decay from satellite states and 4d 5s double ionization.

## 4 Conclusion

We have developed a new powerful setup for electron(s)-ion coincidences. This system offers many advantages. It allows efficient detection of ions and electrons in coincidence at a high repetition rate of light pulses without compromising the energy resolution of the magnetic bottle for the electrons. In addition, the chosen geometry and magnets allow a flexible design for good access to an oven and cold trap for future experiments with metal vapors. It was also possible to use this setup to disentangle the electron spectra from gas mixtures and it was very easy to obtain the He I (21.21 eV) well-known electron spectra of  $\text{O}_2$ ,  $\text{N}_2$  and Ar with air. This could be also important when studying metal vapors in case of the presence of impurities (other alkali metals...).

## Conflicts of interest

There are no conflicts to declare.

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## Notes and references

- H. Hertz, *Ann. Phys.*, 1887, **267**, 983–1000.
- W. Hallwachs, *Ann. Phys.*, 1888, **269**, 301–312.
- P. Lenard, *Ann. Phys.*, 1902, **313**, 149–198.
- A. Einstein, *Ann. Phys.*, 1905, **322**, 132–148.
- J. Jenkin, R. Leckey and J. Liesegang, *J. Electron Spectrosc. Relat. Phenom.*, 1977, **12**, 1–35.
- K. Siegbahn, C. Nordling, A. Fahlman, R. Nordberg, K. Hamrin, J. Hedman, G. Johansson, T. Bergmark, S. Karlsson, I. Lindgren and B. Lindberg, *Nova Acta Reg Soc Sci Upsaliensis Ser. IV*, 20 Uppsala, 1967.
- H. P. Bonzel and C. Kleint, *Prog. Surf. Sci.*, 1995, **49**, 107–153.
- T. Koopmans, *Physica*, 1934, **1**, 104–113.
- I. Suzuki, Y. Hikosaka, E. Shigemasa, P. Lablanquie, F. Penent, K. Soejima, M. Nakano, N. Kouchi and K. Ito, *J. Phys. B: At., Mol. Opt. Phys.*, 2011, **44**, 075003.
- A. Kochur, V. Sukhorukov, A. Dudenko and P. V. Demekhin, *J. Phys. B: At., Mol. Opt. Phys.*, 1995, **28**, 387.
- R. Wehlitz, M.-T. Huang, B. DePaola, J. Levin, I. Sellin, T. Nagata, J. Cooper and Y. Azuma, *Phys. Rev. Lett.*, 1998, **81**, 1813.
- A. Huetz and J. Mazeau, *Phys. Rev. Lett.*, 2000, **85**, 530.
- H. Bräuning, R. Dörner, C. Cocke, M. Prior, B. Krässig, A. Kheifets, I. Bray, A. Bräuning-Demian, K. Carnes and S. Dreuil, *J. Phys. B: At., Mol. Opt. Phys.*, 1998, **31**, 5149.
- T. Weber, A. O. Czasch, O. Jagutzki, A. Müller, V. Mergel, A. Kheifets, E. Rotenberg, G. Meigs, M. H. Prior and S. Daveau, *et al.*, *Nature*, 2004, **431**, 437–440.
- F. Martn, J. Fernández, T. Havermeier, L. Foucar, T. Weber, K. Kreidi, M. Schoffler, L. Schmidt, T. Jahnke and O. Jagutzki, *et al.*, *Science*, 2007, **315**, 629–633.
- R. Dörner, V. Mergel, O. Jagutzki, L. Spielberger, J. Ullrich, R. Moshhammer and H. Schmidt-Böcking, *Phys. Rep.*, 2000, **330**, 95–192.
- P. Selles, L. Malegat and A. Kazansky, *Phys. Rev. A: At., Mol., Opt. Phys.*, 2002, **65**, 032711.
- C. W. McCurdy, D. A. Horner, T. N. Rescigno and F. Martin, *Phys. Rev. A: At., Mol., Opt. Phys.*, 2004, **69**, 032707.
- W. Vanroose, F. Martin, T. N. Rescigno and C. W. McCurdy, *Science*, 2005, **310**, 1787–1789.
- J. Viehhaus, A. N. Grum-Grzhimailo, N. M. Kabachnik and U. Becker, *J. Electron Spectrosc. Relat. Phenom.*, 2004, **141**, 121–126.
- J. H. Eland, O. Vieuxmaire, T. Kinugawa, P. Lablanquie, R. Hall and F. Penent, *Phys. Rev. Lett.*, 2003, **90**, 053003.
- P. Kruit and F. Read, *J. Phys. E: Sci. Instrum.*, 1983, **16**, 313.
- G. Beamson, H. Porter and D. Turner, *J. Phys. E: Sci. Instrum.*, 1980, **13**, 64.
- P. Lablanquie, F. Penent and Y. Hikosaka, *J. Phys. B: At., Mol. Opt. Phys.*, 2016, **49**, 182002.



- 25 Y. Hikosaka, P. Lablanquie, F. Penent, T. Kaneyasu, E. Shigemasa, R. Feifel, J. Eland and K. Ito, *Phys. Rev. Lett.*, 2009, **102**, 013002.
- 26 J. H. Eland, P. Linusson, L. Hedin, E. Andersson, J.-E. Rubensson and R. Feifel, *Phys. Rev. A: At., Mol., Opt. Phys.*, 2008, **78**, 063423.
- 27 Y. Hikosaka, P. Lablanquie, F. Penent, J. Palaudoux, L. Andric, K. Soejima, E. Shigemasa, I. Suzuki, M. Nakano and K. Ito, *Phys. Rev. Lett.*, 2011, **107**, 113005.
- 28 J. Palaudoux, P. Lablanquie, L. Andric, K. Ito, E. Shigemasa, J. Eland, V. Jonauskas, S. Kučas, R. Karazija and F. Penent, *Phys. Rev. A: At., Mol., Opt. Phys.*, 2010, **82**, 043419.
- 29 E. Andersson, S. Fritzsche, P. Linusson, L. Hedin, J. H. Eland, J.-E. Rubensson, L. Karlsson and R. Feifel, *Phys. Rev. A: At., Mol., Opt. Phys.*, 2010, **82**, 043418.
- 30 F. Penent, J. Palaudoux, P. Lablanquie, L. Andric, R. Feifel and J. Eland, *Phys. Rev. Lett.*, 2005, **95**, 083002.
- 31 E. Andersson, P. Linusson, S. Fritzsche, L. Hedin, J. H. Eland, L. Karlsson, J.-E. Rubensson and R. Feifel, *Phys. Rev. A: At., Mol., Opt. Phys.*, 2012, **85**, 032502.
- 32 M. Khalal, P. Lablanquie, L. Andric, J. Palaudoux, F. Penent, K. Bučar, M. Žitnik, R. Püttner, K. Jänkälä and D. Cubaynes, *et al.*, *Phys. Rev. A*, 2017, **96**, 013412.
- 33 S. Matoba, R. Takahashi, C. Io, T. Koizumi and H. Shiromaru, *Jpn. J. Appl. Phys.*, 2011, **50**, 112201.
- 34 S. Matoba, G. Ishikawa, S. Moriya, K. Takahashi, T. Koizumi and H. Shiromaru, *Rev. Sci. Instrum.*, 2014, **85**, 086105.
- 35 K. Fehre, D. Trojanowskaja, J. Gatzke, M. Kunitski, F. Trinter, S. Zeller, L. P. H. Schmidt, J. Stohner, R. Berger and A. Czasch, *et al.*, *Rev. Sci. Instrum.*, 2018, **89**, 045112.
- 36 F. Penent, M. Nakano, M. Tashiro, T. Grozdanov, M. Žitnik, K. Bučar, S. Carniato, P. Selles, L. Andric and P. Lablanquie, *et al.*, *J. Electron Spectrosc. Relat. Phenom.*, 2015, **204**, 303–312.
- 37 A. H. Roos, J. Eland, J. Andersson, S. Zagorodskikh, R. Singh, R. Squibb and R. Feifel, *Phys. Chem. Chem. Phys.*, 2016, **18**, 25705–25710.
- 38 L. Frasinski, M. Stankiewicz, P. Hatherly and K. Codling, *Meas. Sci. Technol.*, 1992, **3**, 1188.
- 39 A. E. Slattery, T. A. Field, M. Ahmad, R. I. Hall, P. Lablanquie and F. Penent, *Meas. Sci. Technol.*, 2002, **13**, 2007.
- 40 A. Hans, C. Ozga, P. Schmidt, G. Hartmann, A. Nehls, P. Wenzel, C. Richter, C. Lant, X. Holzapfel and J. Viehmann, *et al.*, *Rev. Sci. Instrum.*, 2019, **90**, 093104.
- 41 A. Matsuda, M. Fushitani, C.-M. Tseng, Y. Hikosaka, J. H. Eland and A. Hishikawa, *Rev. Sci. Instrum.*, 2011, **82**, 103105.
- 42 J. H. Eland, P. Linusson, M. Mucke and R. Feifel, *Chem. Phys. Lett.*, 2012, **548**, 90–94.
- 43 K. Ito, F. Penent, Y. Hikosaka, E. Shigemasa, I. H. Suzuki, J. H. Eland and P. Lablanquie, *Rev. Sci. Instrum.*, 2009, **80**, 123101.
- 44 J. Eland, C. Slater, S. Zagorodskikh, R. Singh, J. Andersson, A. Hult-Roos, A. Lauer, R. Squibb and R. Feifel, *J. Phys. B: At., Mol. Opt. Phys.*, 2015, **48**, 205001.
- 45 J. H. Eland and R. Feifel, *Chem. Phys.*, 2006, **327**, 85–90.
- 46 S. Deinert, *Aufbau eines hocheffizienten Photoelektronen-Photoion-Koinzidenzexperiment/ Setup of a Highly Efficient Photoelectron-Photoion-Coincidence-Experiment*, PhD thesis, Fachbereich Physik der Universität Hamburg, 2013.
- 47 J. Palaudoux, S. Sheinerman, J. Soronen, S.-M. Huttula, M. Huttula, K. Jänkälä, L. Andric, K. Ito, P. Lablanquie and F. Penent, *et al.*, *Phys. Rev. A: At., Mol., Opt. Phys.*, 2015, **92**, 012510.
- 48 M. Khalal, J. Soronen, K. Jänkälä, S. Huttula, M. Huttula, J. Bizau, D. Cubaynes, S. Guillaud, K. Ito and L. Andric, *et al.*, *J. Phys. B: At., Mol. Opt. Phys.*, 2017, **50**, 225003.
- 49 J. Keskinen, P. Lablanquie, F. Penent, J. Palaudoux, L. Andric, D. Cubaynes, J.-M. Bizau, M. Huttula and K. Jänkälä, *Phys. Rev. A*, 2017, **95**, 043402.
- 50 K. Ross and B. Sonntag, *Rev. Sci. Instrum.*, 1995, **66**, 4409–4433.
- 51 O. Chubar, P. Elleaume and J. Chavanne, RADIA package (ESRF), <https://www.esrf.fr/Accelerators/Groups/InsertionDevices/Software/Radia>.
- 52 F. Bloch, O. Cugat, G. Meunier and J. Toussaint, *IEEE Trans. Magn.*, 1998, **34**, 2465–2468.
- 53 J. Eland, *Meas. Sci. Technol.*, 1993, **4**, 1522.
- 54 F. Penent, R. Hall, R. Panajotović, J. Eland, G. Chaplier and P. Lablanquie, *Phys. Rev. Lett.*, 1998, **81**, 3619.
- 55 E. B. Saloman, *J. Phys. Chem. Ref. Data*, 2004, **33**, 765–921.
- 56 A. Ausmees, S. Osborne, S. Svensson, A. N. de Brito, O.-P. Sairanen, A. Kivimäki, E. Nömmiste, H. Aksela and S. Aksela, *Phys. Rev. A: At., Mol., Opt. Phys.*, 1995, **52**, 2943.
- 57 A. Kramida, Yu Ralchenko, J. Reader and NIST ASD Team, NIST Atomic Spectra Database (ver. 5.9), National Institute of Standards and Technology, Gaithersburg, MD, 2021, [Online]. Available: <https://physics.nist.gov/asd> [2022, June 20].
- 58 Y. Hikosaka, P. Lablanquie, F. Penent, T. Kaneyasu, E. Shigemasa, J. Eland, T. Aoto and K. Ito, *Phys. Rev. Lett.*, 2007, **98**, 183002.